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Application/Control No.	Applicant(s)/Patent under Reexamination
10/827,285	CHEN ET AL.
Examiner	Art Unit
Devin Hanan	3745

	SEAR	CHED	
Class	Subclass	Date	Examiner
415	185		
	186R		
	189		
	178		
	234	9/17/2005	DH

INT	ERFERENC	RFERENCE SEARCHED		
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR		<u> </u>
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